

BUK9880-55A

N-channel TrenchMOS logic level FET

Rev. 02 — 12 April 2007

Product data sheet

1. Product profile

1.1 General description

N-channel enhancement mode power Field-Effect Transistor (FET) in a plastic package using NXP General Purpose Automotive (GPA) TrenchMOS technology.

1.2 Features

- Very low on-state resistance
- 150 °C rated
- Q101 compliant
- Logic level compatible

1.3 Applications

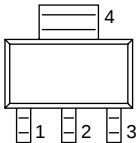
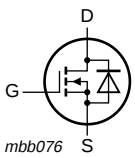
- Automotive systems
- Motors, lamps and solenoids
- General purpose power switching
- 12 V and 24 V loads

1.4 Quick reference data

- $E_{DS(AL)S} \leq 36 \text{ mJ}$
- $I_D \leq 7 \text{ A}$
- $R_{DS(on)} = 68 \text{ m}\Omega$ (typ)
- $P_{tot} \leq 8 \text{ W}$

2. Pinning information

Table 1. Pinning

Pin	Description	Simplified outline	Symbol
1	gate (G)	 SOT223 (SC-73)	 mbb076
2	drain (D)		
3	source (S)		
4	solder point; connected to drain (D)		

3. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
BUK9880-55A	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223

4. Limiting values

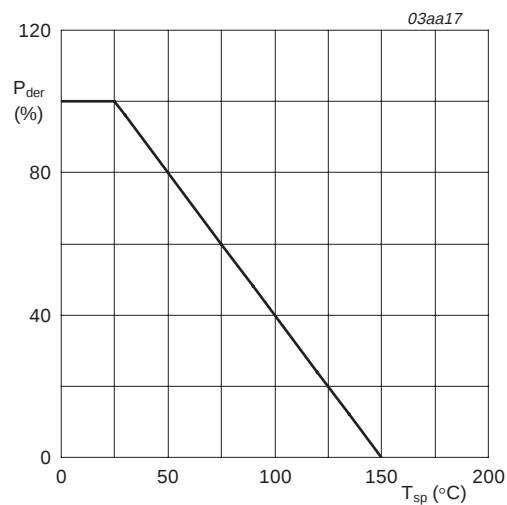
Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	55	V
V_{DGR}	drain-gate voltage (DC)	$R_{GS} = 20\text{ k}\Omega$	-	55	V
V_{GS}	gate-source voltage		-	± 15	V
I_D	drain current	$T_{sp} = 25\text{ }^\circ\text{C}$; $V_{GS} = 5\text{ V}$; see Figure 2 and 3	-	7	A
		$T_{sp} = 100\text{ }^\circ\text{C}$; $V_{GS} = 5\text{ V}$; see Figure 2	-	4	A
I_{DM}	peak drain current	$T_{sp} = 25\text{ }^\circ\text{C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; see Figure 3	-	30	A
P_{tot}	total power dissipation	$T_{sp} = 25\text{ }^\circ\text{C}$; see Figure 1	-	8	W
T_{stg}	storage temperature		-55	+150	$^\circ\text{C}$
T_j	junction temperature		-55	+150	$^\circ\text{C}$
Source-drain diode					
I_{DR}	reverse drain current	$T_{sp} = 25\text{ }^\circ\text{C}$	-	7	A
I_{DRM}	peak reverse drain current	$T_{sp} = 25\text{ }^\circ\text{C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	30	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 6\text{ A}$; $V_{DS} \leq 55\text{ V}$; $R_{GS} = 50\text{ }\Omega$; $V_{GS} = 5\text{ V}$; starting at $T_j = 25\text{ }^\circ\text{C}$	-	36	mJ
$E_{DS(AL)R}$	repetitive drain-source avalanche energy	[1]	-	-	

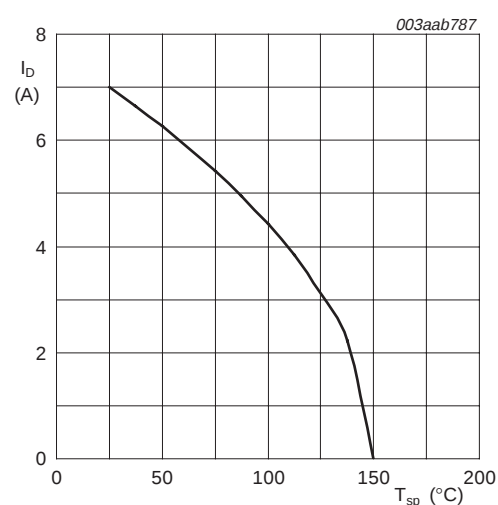
[1] Conditions:

- Maximum value not quoted. Repetitive rating defined in [Figure 16](#).
- Single-pulse avalanche rating limited by $T_{j(max)}$ of $150\text{ }^\circ\text{C}$.
- Repetitive avalanche rating limited by an average junction temperature of $145\text{ }^\circ\text{C}$.
- Refer to application note *AN10273* for further information.



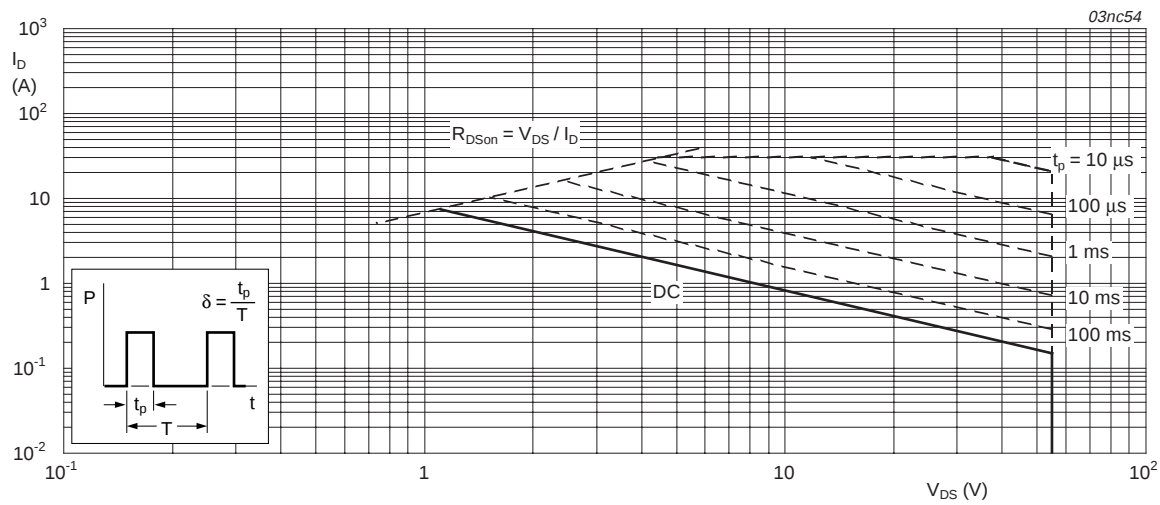
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature



$$V_{GS} \geq 5 \text{ V}$$

Fig 2. Continuous drain current as a function of solder point temperature



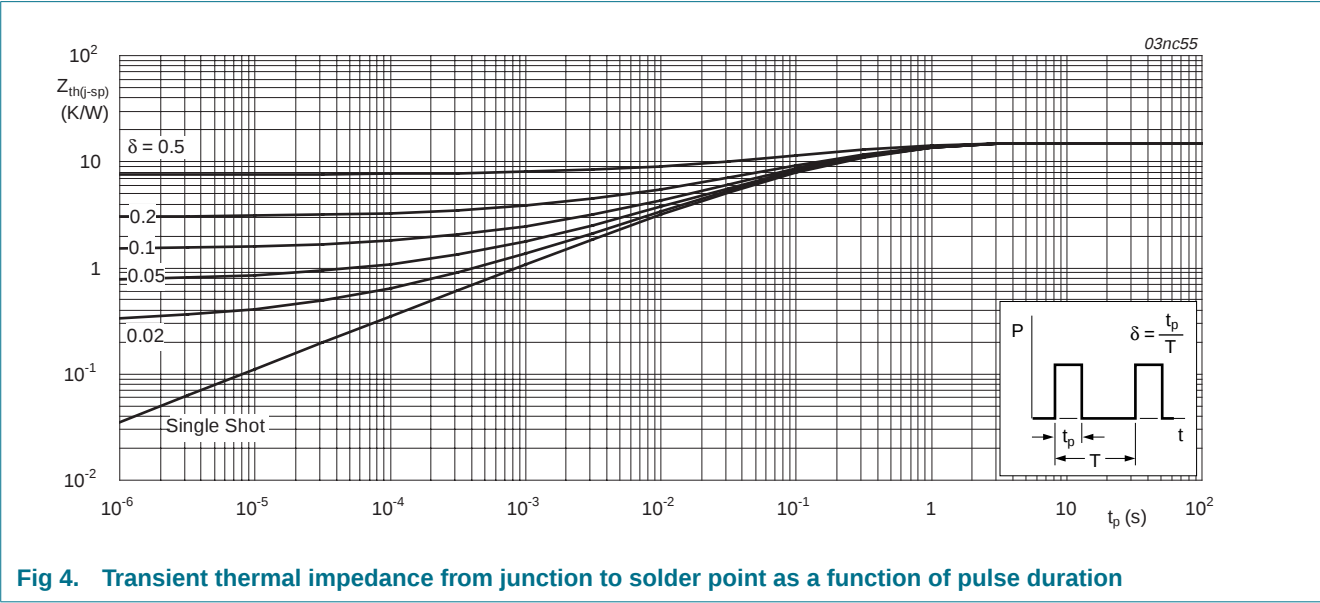
$$T_{sp} = 25^{\circ}C; I_{DM} \text{ is single pulse.}$$

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient		-	70	-	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	15	K/W



6. Characteristics

Table 5. Characteristics

$T_j = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
V _{(BR)DSS}	drain-source breakdown voltage	I _D = 250 μA; V _{GS} = 0 V				
		T _j = 25 °C	55	-	-	V
		T _j = −55 °C	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; see Figure 9 and 10				
		T _j = 25 °C	1	1.5	2	V
		T _j = 150 °C	0.6	-	-	V
		T _j = −55 °C	-	-	2.3	V
I _{DSS}	drain leakage current	V _{DS} = 55 V; V _{GS} = 0 V				
		T _j = 25 °C	-	0.05	10	μA
		T _j = 150 °C	-	-	500	μA
I _{GSS}	gate leakage current	V _{GS} = ±10 V; V _{DS} = 0 V	-	2	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 5 V; I _D = 8 A; see Figure 7 and 8				
		T _j = 25 °C	-	68	80	mΩ
		T _j = 150 °C	-	-	147	mΩ
		V _{GS} = 4.5 V; I _D = 8 A	-	-	89	mΩ
		V _{GS} = 10 V; I _D = 8 A	-	62	73	mΩ
Dynamic characteristics						
Q _{G(tot)}	total gate charge	I _D = 10 A; V _{DD} = 44 V; V _{GS} = 5 V; see Figure 14	-	11	-	nC
Q _{GS}	gate-source charge		-	1.6	-	nC
Q _{GD}	gate-drain charge		-	4.6	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz; see Figure 12	-	438	584	pF
C _{oss}	output capacitance		-	87	104	pF
C _{rss}	reverse transfer capacitance		-	62	85	pF
t _{d(on)}	turn-on delay time	V _{DS} = 30 V; R _L = 1.2 Ω; V _{GS} = 5 V; R _G = 10 Ω	-	8	-	ns
t _r	rise time		-	118	-	ns
t _{d(off)}	turn-off delay time		-	20	-	ns
t _f	fall time		-	32	-	ns
Source-drain diode						
V _{SD}	source-drain voltage	I _S = 15 A; V _{GS} = 0 V; see Figure 15	-	0.85	1.2	V
t _{rr}	reverse recovery time	I _S = 20 A; dI _S /dt = −100 A/μs;	-	33	-	ns
Q _r	recovered charge	V _{GS} = −10 V; V _R = 30 V	-	60	-	nC

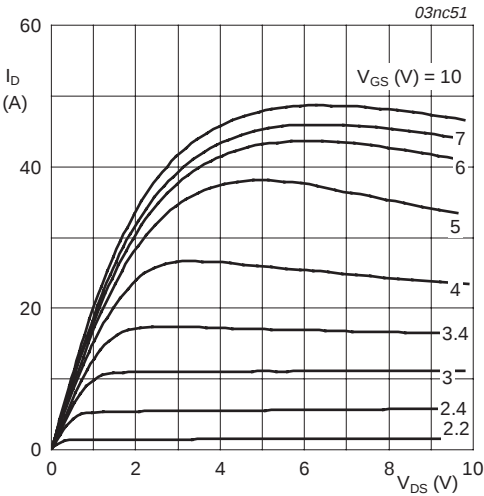


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

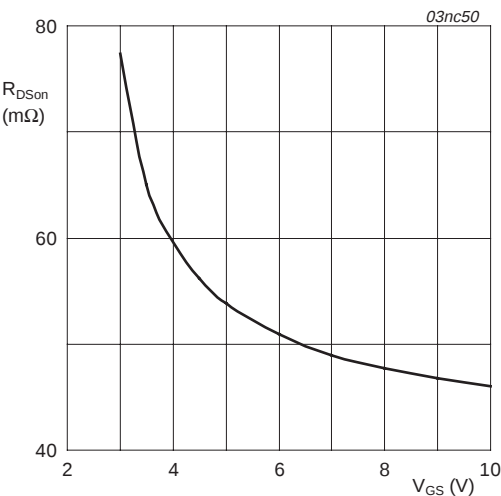


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

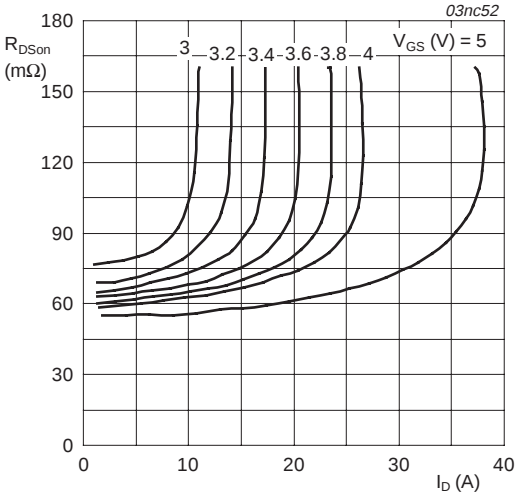
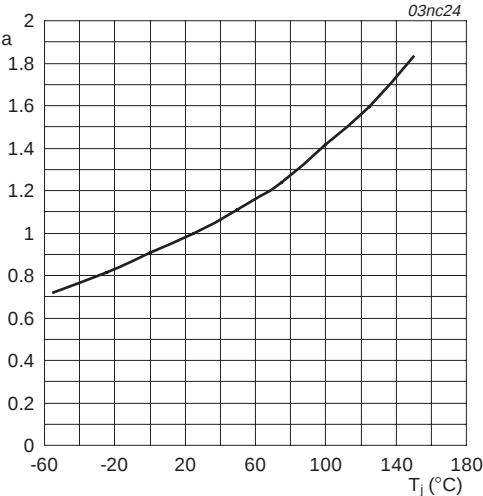
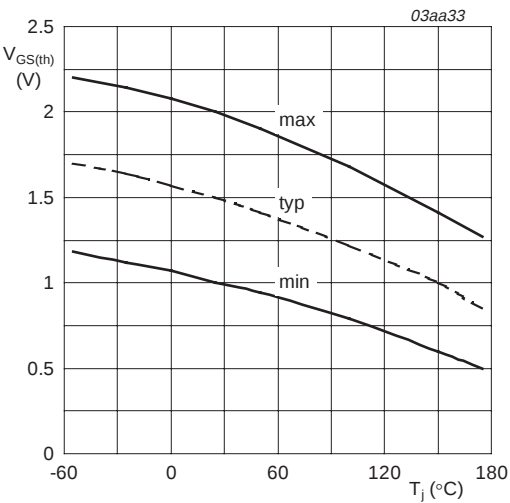


Fig 7. Drain-source on-state resistance as a function of drain current; typical values



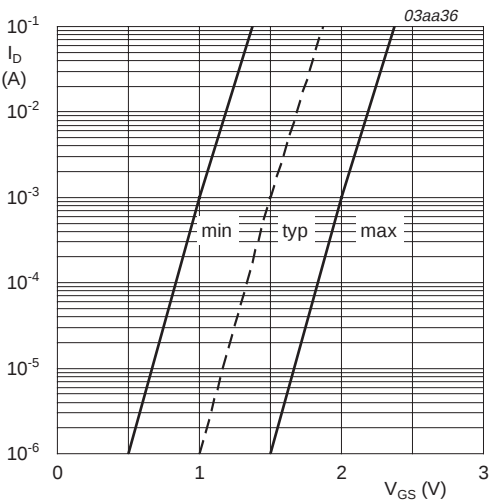
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



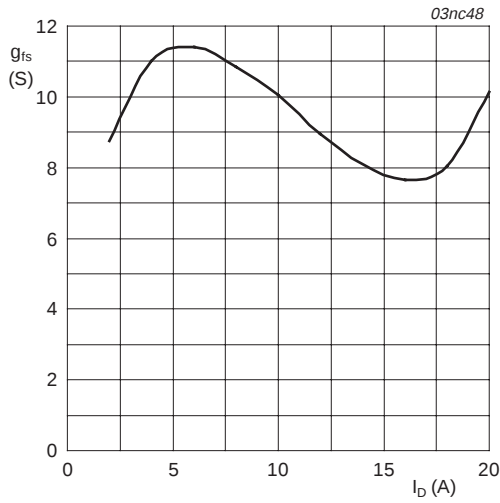
$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



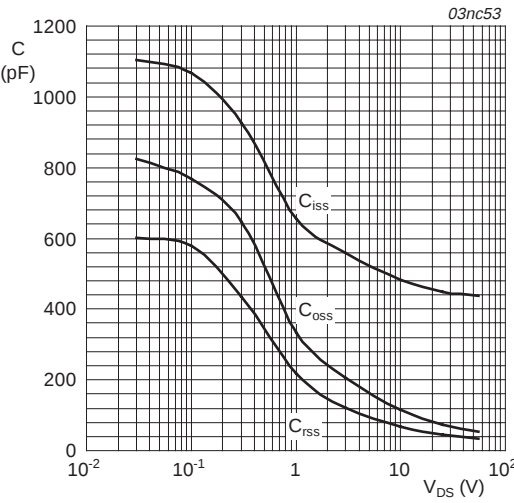
$T_j = 25\text{ }^{\circ}C; V_{DS} = V_{GS}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



$T_j = 25\text{ }^{\circ}C; V_{DS} = 25\text{ V}$

Fig 11. Forward transconductance as a function of drain current; typical values



$V_{GS} = 0\text{ V}; f = 1\text{ MHz}$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

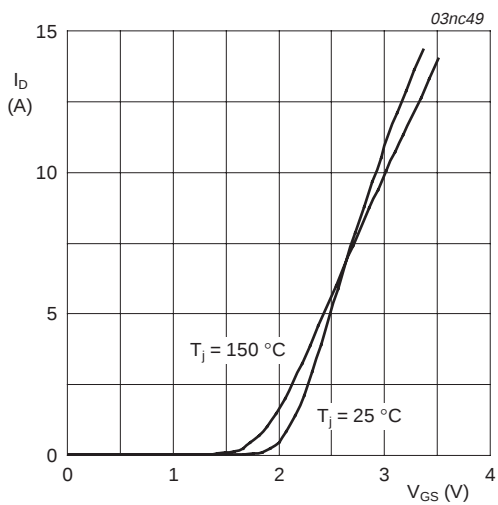


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

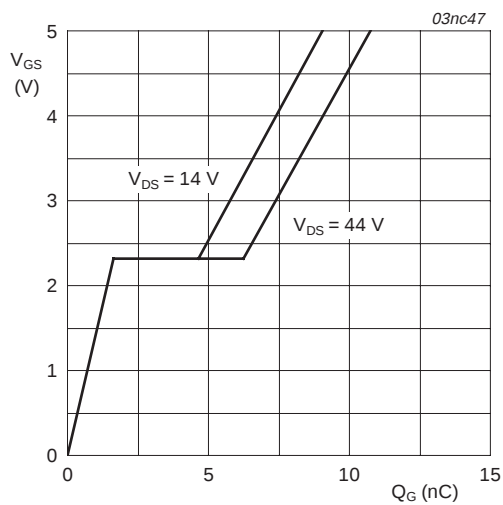


Fig 14. Gate-source voltage as a function of gate charge; typical values

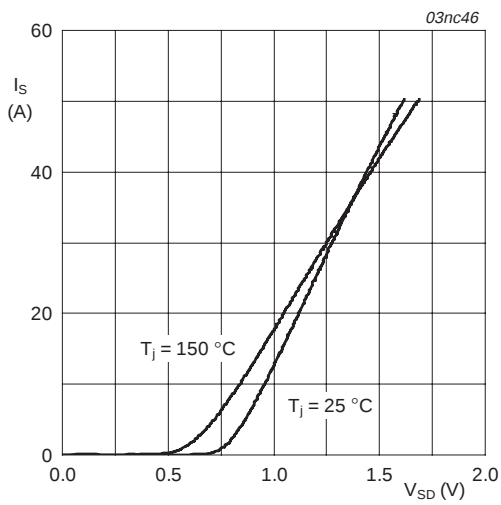
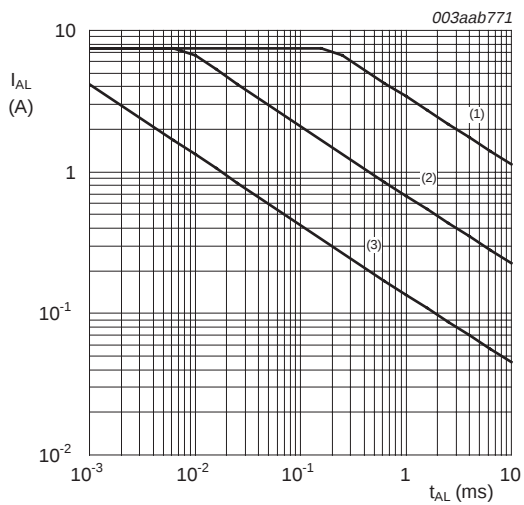


Fig 15. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values



See [Table note 1](#) of [Table 3 "Limiting values"](#).

- (1) Single-pulse; $T_J = 25\text{ }^{\circ}\text{C}$.
- (2) Single-pulse; $T_J = 125\text{ }^{\circ}\text{C}$.
- (3) Repetitive.

Fig 16. Single-pulse and repetitive avalanche rating; avalanche current as a function of avalanche time

7. Package outline

Plastic surface-mounted package with increased heatsink; 4 leadsSOT223

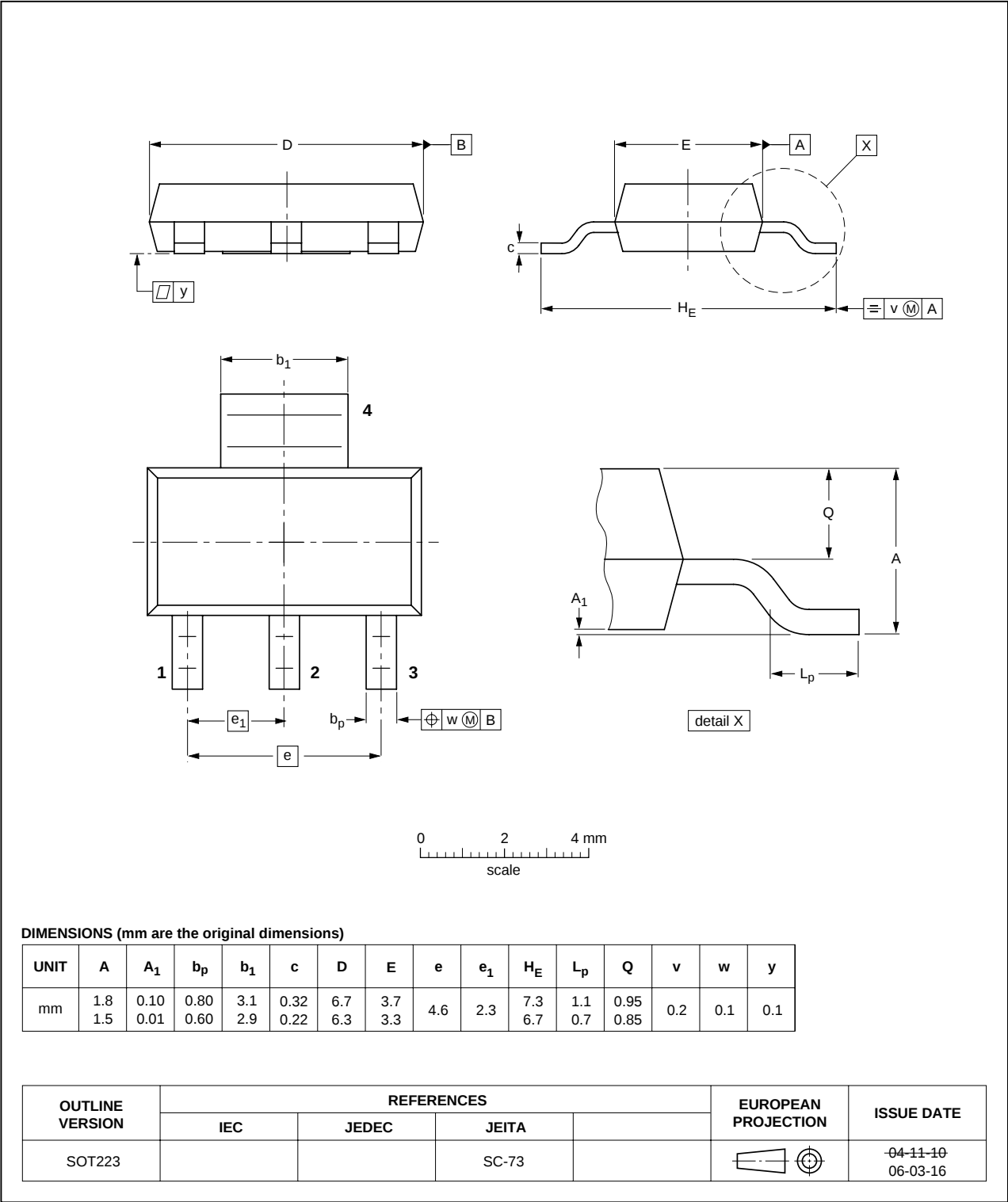


Fig 17. Package outline SOT223 (SC-73)

8. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK9880-55A_2	20070412	Product data sheet	-	BUK9880_55A-01
Modifications:	• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. • Legal texts have been adapted to the new company name where appropriate. • Section 4 "Limiting values": corrected V_{GS} value from ± 10 V to ± 15 V.			
BUK9880_55A-01 (9397 750 07736)	20010207	Product specification	-	-

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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